Title
Nanoscale structure and mechanism for enhanced electromechanical response of highly strained BiFeO3 thin films

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The nanostructural evolution of the strain-induced structural phase transition in BiFeO₃ is examined. Using high-resolution X-ray diffraction and scanning-probe-microscopy-based studies we have uniquely identified and examined the numerous phases present at the phase boundaries and have discovered an intermediate monoclinic phase in addition to the previously observed rhombohedral- and tetragonal-like phases. Further analysis has determined that the so-called mixed-phase regions of these films are not mixtures of rhombohedral- and tetragonal-like phases, but intimate mixtures of highly distorted monoclinic phases with no evidence for the presence of the rhombohedral-like parent phase. Finally, we propose a mechanism for the enhanced electromechanical response in these films including how these phases interact at the nanoscale to produce large surface strains.

Piezoelectric materials have been used in a wide array of technologies and are potential candidates for energy harvesting and memory applications. State-of-the-art piezoelectrics are based on perovskite materials with complex chemistries including Pb(ZrxTi1-x)O₃ (PZT) at x = 0.33 and (1-x)Pb(Mg1/3Nb2/3)O₃-PbTiO₃ (PMN-PT) at x = 0.33. Special attention has been given to these materials due to the presence of morphotropic phase boundaries (MPB), or a nearly temperature insensitive, compositional driving force for the enhanced electromechanical response. Using epitaxial thin-film growth, X-ray reciprocal space mapping (RSM), atomic and piezoresponse force microscopy (AFM and FFM), we report the nanoscale structural evolution of such strain-induced phase boundaries in BiFeO₃. We report on the true structure of these phase boundaries, including the observation of never before reported phases, the nanoscale spatial location of these phases, as well as the interplay between these phases and how this results in strong electromechanical actuation in these materials. These concepts represent unique and timely advances in our understanding of this technologically relevant material.

BiFeO₃ is a rhombohedrally distorted (R3c) multiferroic perovskite exhibiting antiferromagnetism that is coupled with ferroelectric order. Although the structure of BiFeO₃ had been studied for many years, in 2005 the structural stability of the parent phase had come into question. An exhaustive high-temperature neutron-diffraction study of bulk BiFeO₃ powders examined the complex structure and phases in this material and reported that both the β- and γ-phases are orthorhombic and that there is no evidence for a monoclinic phase in unstrained BiFeO₃. Other thin-film studies, however, have shown that a tetragonally distorted phase (derived from a structure with Pnma symmetry, a = 3.665 Å and c = 4.655 Å) with a large spontaneous polarization may be possible. Furthermore, so-called mixed-phase thin films possessing tetragonal- and rhombohedral-like phases in complex stripe-like structures that give rise to enhanced electromechanical responses were also reported. Since this report, additional information has come forth about these materials including the fact that the tetragonal-like phase is actually monoclinically distorted (possessing Cc, Cm, Pm, or Pc symmetry). Nonetheless, a thorough understanding of the complex structure of these phase boundaries in BiFeO₃ remains incomplete. Building on our understanding of structure and response in chemically driven MPB systems, the current work uniquely identifies the boundary nanostructure and the pathway for enhanced electromechanical response in BiFeO₃ films.

Epitaxial BiFeO₃ thin films of thickness 20–200 nm were deposited by pulsed laser deposition from a Bi₁₋ₓFeₓO₃ target at 700 °C in oxygen pressures of 100 mTorr on single-crystal LaAlO₃ (001) substrates and were cooled at 760 Torr. Detailed structural information was obtained using high-resolution reciprocal space maps (RSM) (X’Pert MRD Pro, PANalytical). The film topography was studied with AFM and piezoresponse, ferroelectric, and switching studies were completed using PFM (Cypher, Asylum Research).
Consistent with prior reports, films less than \( \approx 40 \) nm thick exhibited only the distorted tetragonal-like phase. The complexity of this system requires a rigorous definition of the phases present, thus throughout the remainder of this manuscript, we will refer to this monochromatically distorted tetragonal-like phase as the M\(_{11}\)-phase. AFM of these samples reveals atomic-level terraces with step-heights corresponding to single unit cells (\( \approx 4.65 \) Å) (Figure 1A). A detailed RSM of the 001-diffraction condition (Figure 1B) reveals the presence of only two peaks, the 001-diffraction peak for the LaAlO\(_3\) substrate and that for the M\(_{11}\)-phase of BiFeO\(_3\). As film thickness is increased (shown here is data for a 130 nm thick film) regions of pure M\(_{11}\)-phase (bright areas, Figure 1C) and mixed-phase regions (striped areas, Figure 1C) are observed. Early reports suggested that these mixed-phase regions were an intimate mixture of the tetragonal- and rhombohedral-like phases. In turn, we will provide evidence of a more complex nanostructural arrangement. We will henceforth refer to the monochromatically distorted rhombohedral bulk-like phase as the R-phase. Both these results and the results of previous works focusing on this R-phase\([25–27]\) reveal similar lattice parameters and monoclinic distortions. The RSM of the 001-diffraction condition of this film (Figure 1D) reveals significant complexity. Peaks corresponding to the 001-diffraction peak of the substrate, the R-phase (\( c = 3.979 \pm 0.003 \) Å), and the M\(_{11}\)-phase (\( c = 4.667 \pm 0.005 \) Å) are labeled accordingly. The peak corresponding to the R-phase has very low intensity and this peak has been found to be absent in other films. Additionally, there are two new sets of diffraction peaks. The first set is located on either side of the M\(_{11}\)-phase peak in Q\(_x\)-space at a Q\(_y\)-value of \( \approx 1640 \) (where Q\(_i\) is the \( i \)th component of the reciprocal space vector and \( d \) is the interplane spacing) (labeled as M\(_{11}\),tilt, Figure 1D).

These peaks correspond to a phase that possesses the same \( c \) (4.667 Å) as the M\(_{11}\)-phase, but is tilted by \( \approx 1.53^{\circ} \) along the [100] relative to the [001] sample normal. The second set comprises four diffraction peaks at Q\(_y\) \( \approx 1850 \), which represent a previously unobserved phase, henceforth referred to as an intermediate monoclinic phase (M\(_I\)-phase). The M\(_I\)-phase has \( c = 4.168 \) Å, which is intermediate between the R- and M\(_{11}\)-phases, and exhibits two pairs of peaks. The outer pair suggests this phase is tilted \( \approx 2.88^{\circ} \) along the [100] relative to the [001] sample normal and the inner pair suggests a possible rotation of \( \approx 0.4^{\circ} \) about the sample normal. The outer- and inner-peak pairs are thought to correspond to diffraction from the same phases in the two stripe-sets (rotated by 90° in the plane of the film).

In order to better understand this complex structure, we performed high-resolution RSM studies of a number of off-axis
to the monoclinic distortion reported above and is consistent with prior observations.\[21,28\] High-resolution AFM also provides direct images of the structural features observed in the X-ray diffraction. Evidence for regions of pure M\textsubscript{II}-phase and mixed-phase regions (sawtooth-like features on the surface) are observed in 140 nm thick films (Figure 4A). The mixed phase regions do not possess a flat-bottom or well-like structure, but are sawtooth in nature as demonstrated by the indicative line-trace (dashed-line in Figure 4A, data Figure 4B). We have found that these features are asymmetric and, in this example, the left side of the sawtooth is inclined to the substrate surface with an angle of $\approx 1.8^\circ$, while the right side of the sawtooth is inclined
to the surface at an angle of ≈2.8° This suggests that the phases observed in the X-ray diffraction studies to be tilted by ≈1.6° (M\text{III}-phase) and ≈2.8° (M\text{II}-phase) are located in intimate proximity to one another in the mixed-phase, stripe-regions (Supporting Information, Figure 2). Prior work suggested an intimate mixture of the R- and M\text{II}-phases in these regions, but our data indicates otherwise. Further evidence against this intimate mixture of the R- and M\text{II}-phases is provided in the line-trace parallel to the striplike features (dash-dot line Figure 4A, data Figure 4C) that shows that there is an overall depression of the surface height of ≈5 nm in the mixed-phase regions. Surface depressions are consistent with the presence of the M\text{I}-phase, but not of an intimate mixture of R- and M\text{II}-phases, but an intimate mixture of highly distorted (or tilted), monoclinic phases, in particular the M\text{I} and M\text{II,tilt}-phases. Application of electric fields to these mixed-phase samples results in strong electromechanical responses. Local switching studies using PFM reveal surface electromechanical strains as large as 4–5% (Figure 4). In order to better understand the mechanism for such large electromechanical responses, we studied the evolution of the surface structure and polarization of a 1 μm × 1 μm region of a mixed-phase 100 nm BiFeO\textsubscript{3}/5 nm La\textsubscript{0.5}Sr\textsubscript{0.5}CoO\textsubscript{3}/5 nm LaAlO\textsubscript{3} (001) thin film by applying different voltages to the region within the box in Figure 5A using PFM. After each applied voltage, we captured both the topography (left images Figure 5) and the out-of-plane orientation of the polarization (right images Figure 5). In the as-grown configuration, the film possesses a mixed-phase structure and is entirely down polarized (Figure 5A). Upon applying a 5.25 V potential, we have observed no change in the surface structure or out-of-plane polarization (Figure 5B). Upon further increasing the applied potential to 10.25 V, however, we observe the ability to electrically drive the mixed-phase region to be entirely made-up of the M\text{II}-phase (Figure 5C). If we then begin to drive the same region with small negative potentials (e.g., −3 V), we observe the ability to completely and reversibly switch the material back into a mixed-phase structure similar to the as-grown configuration (Figure 5D). Further increasing the negative potential to −5.25 V results in ferroelectrically switching the material (Figure 5E), but maintains the mixed-phase structure. Application of large negative biases (~9 V) results in the eventual transformation of the mixed-phase structure into an upward-poled version of the M\text{II}-phase (Figure 5F). The polarization of this M\text{II}-phase is pointing opposite to that in the structure shown in Figure 5C. If we now apply positive potentials to this region we can return to the mixed-phase structure similar to the as-grown state, but with a reversed out-of-plane polarization (Figure 5G). Finally, by further increasing to a positive potential of 5.25 V we return the structure and polarization to the as-grown configuration (Figure 5H).

By navigating the hysteretic nature of electric field response in this material, we have learned a number of important features of this system. First, large surface strains of 4–5% occur any time the material transforms form a mixed-phase structure to the M\text{II}-phase. Second, these transformations between these two states are entirely reversible. Third, there are numerous pathways to achieve large electromechanical responses in these materials. The first, as described in Figure 5A–H and in the corresponding schematic hysteresis loop in Figure 5I, occurs upon traversing the entire hysteresis loop. Following the path from (A) to (H) in Figure 5I, the material undergoes four transformations that give rise to large surface strains. Traversing this major hysteresis loop requires the input of considerable energy and two ferroelectric polarization switching events. On the other hand, we can achieve the same large electromechanical responses without the need to ferroelectrically switch the sample. By following the minor hysteresis loops B–C–D–B or E–F–G–E (one is highlighted in Figure 5I), we can repeatedly transform between the mixed-phase structure and the M\text{II}-phase, thereby obtaining large electromechanical responses without switching the polarization direction. This is an exciting discovery and could have important implications for utilization of these materials in devices including possible low-power applications.

Finally, we propose a mechanism for this enhanced electromechanical response. The key appears to be the ability to transform from the M\text{II}-phase to the M\text{II,tilt}-phase to the M\text{II}-phase through a diffusion-less phase transition. Focusing on the minor hysteresis loop B–C–D–B and our step-by-step probing of the material, it appears that the application of a positive potential drives the preferential growth of the M\text{II,tilt}-phase at the expense of the M\text{II}-phase in the mixed-phase regions (Figure 5I) until a purely M\text{II,tilt} region is obtained. At this point the material

Figure 4. AFM images of 100 nm and 50 nm BiFeO\textsubscript{3}/La\textsubscript{0.5}Sr\textsubscript{0.5}CoO\textsubscript{3}/LaAlO\textsubscript{3} (001) heterostructures in (A,D) the as-grown state and B,E) following electrical poling. C,D) Corresponding line traces at the black lines.
undergoes a final rotation of the polarization towards the surface normal and the development of the $M_{II}$-phase, which has preferential alignment of polarization relative to the applied field direction. We note that we cannot uniquely identify if this polarization rotation occurs only after the material has transformed to the $M_{II}$-phase or if it gradually happens during the transformation. From a geometrical argument, however, one might expect gradual rotation of the polarization during the growth of the $M_{II,tilt}$-phase as the tilt is no longer needed to accommodate the $M_{II}$-phase and the elastic strain. Regardless, at this point the $M_{II}$-phase is stable and only upon application of negative potentials does the sample undergo a reversal of the transformation and return to the as-grown structure. Such a hysteresis loop provides the actuation and deactuation of the large surface displacement required for applications.

In conclusion, these results have shown that the added complexity associated with the strain-induced structural phase boundaries in BiFeO$_3$ films are key in determining the response of these materials to applied fields. We have observed that the films possess a number of phases including the $M_1$, $M_{II}$, and $M_{II,tilt}$-phases, that the mixed-phase regions consist of an intimate mixture of two highly tilted, monoclinic phases ($M_1$- and $M_{II,tilt}$-phases) and have provided a proposed mechanism to describe how the material can easily transform between structural polymorphs under applied electric-fields and produce strong electromechanical responses. Such unique behavior has significant implications for numerous applications and could help shed light on similar boundaries in other high-performance piezoelectrics.

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